

**Search Notes**

Application/Control No.

10/069,750

Examiner

George R. Evanisko


Applicant(s)/Patent under  
Reexamination

YOON ET AL.

Art Unit

3762

**SEARCHED**

| Class | Subclass | Date      | Examiner  |
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**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

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